

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10537473	BUECHLER ET AL.
	Examiner	Art Unit
	Barker, Matthew	3662

SEARCHED

Class	Subclass	Date	Examiner
342	70-72	7/17/2007	Hien Ly
342	201,203,159,128,132	7/18/2007	Hien Ly
342	52	6/20/2008	MMB
	updated 342/52	1/13/2009	MMB

SEARCH NOTES

Search Notes	Date	Examiner
Inventor's name search	7/17/2007	Hien Ly
Plus search	7/17/2007	Hien Ly
NPL search	7/17/2007	Hien Ly
Text search	7/17/2007	Hien Ly
text Search (update)	12/27/2007	Hien Ly
NPL Search (update)	12/27/2007	Hien Ly
342/57, 58, 60, 70-72 text search - see printout	6/20/2008	MMB
New EAST text search - see printout	6/21/2008	MMB
IEEE search - see printout	6/21/2008	MMB
Updated text search	1/13/2009	MMB

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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